intersil

DATASHEET

ISL72028BSEH

3.3V Radiation Tolerant CAN Transceiver, with Low-Power Shutdown, Split Termination Output

FN8902 Rev 0.00 November 30, 2016

The <u>ISL72028BSEH</u> is a radiation tolerant 3.3V CAN transceiver that is compatible with the ISO11898-2 standard for applications calling for Controller Area Network (CAN) serial communication in satellites and aerospace communications, and telemetry data processing in harsh industrial environments.

The transceiver can transmit and receive at bus speeds up to 5Mbps. It can drive a 40m cable at 1Mbps per the ISO11898-2 specification. It was designed to operate over a common-mode range of -7V to +12V with a maximum of 120 nodes. The device has three discrete selectable driver rise/fall time options, a Low-Power Shutdown mode and a split termination output.

Receiver (Rx) inputs feature a "full fail-safe" design, which ensures a logic high Rx output if the Rx inputs are floating, shorted, or terminated but undriven.

The ISL72028BSEH is available in an 8 Ld hermetic ceramic flatpack and die form that operate across the temperature range of -55 °C to +125 °C. The logic inputs are tolerant with 5V systems.

Other CAN transceivers available are the <u>ISL72026BSEH</u> and <u>ISL72027BSEH</u>. For a list of differences see <u>Table 1 on page 2</u>.

Related Literature

- · For a full list of related documents, visit our website
- ISL72028BSEH product page

Applications

- · Satellites and aerospace communications
- Telemetry data processing
- High-end industrial environments
- Harsh environments

Features

- Electrically screened to SMD 5962-15228
- ESD protection on all pins.....4kV HBM
- Compatible with IS011898-2
- Operating supply range 3.0V to 3.6V
- Bus pin fault protection to ±20V
- Undervoltage lockout
- Cold spare: powered-down devices/nodes will not affect active devices operating in parallel
- · Three selectable driver rise and fall times
- Glitch free bus I/O during power-up and power-down
- · Full fail-safe (open, short, terminated/undriven) receiver
- · Hi-Z input allows for 120 nodes on the bus
- High data rates.....up to 5Mbps
- Low-Power Shutdown mode 50µA (maximum)
- -7V to +12V common-mode input voltage range
- 5V tolerant logic inputs
- Thermal shutdown
- · Acceptance tested to 75krad(Si) (LDR) wafer-by-wafer
- Radiation tolerance
- Low dose rate (0.01rad(Si)/s)75krad(Si)
- High dose rate (50-300rad(Si)/s)..... 100krad(Si)



FIGURE 1. TYPICAL APPLICATION



Ordering Information

ORDERING SMD NUMBER (<u>Note 1</u>)	PART NUMBER (Note 2)	TEMPERATURE RANGE (°C)	PACKAGE (RoHS COMPLIANT)	PKG DWG #
5962R1522806VXC	ISL72028BSEHVF	SL72028BSEHVF -55 to +125 8		K8.A
N/A	ISL72028BSEHF/PR0T0, Note 3	/PROTO, Note 3 -55 to +125 8 Ld Ceramic Flatpac		K8.A
5962R1522806V9A	ISL72028BSEHVX	-55 to +125	Die	
N/A	ISL72028BSEHX/SAMPLE, Note 3	-55 to +125	Die	
N/A	ISL72028BSEHEVAL1Z	Evaluation Board		

NOTES:

1. Specifications for radiation tolerant QML devices are controlled by the Defense Logistics Agency Land and Maritime (DLA). The SMD numbers listed must be used when ordering.

2. These Pb-free Hermetic packaged products employ 100% Au plate - e4 termination finish, which is RoHS compliant and compatible with both SnPb and Pb-free soldering operations.

3. The /PROTO and /SAMPLE (Die) have no traceability and are intended for engineering evaluation purposes only. The /PROTO part meets the electrical limits and conditions across temperature (-55°C to +125°C) specified in the datasheet or DLA SMD and is in the same form and fit as the flight devices (Class V parts). The SAMPLE die is capable of meeting the electrical limits and conditions specified in the data sheet or DLA SMD. The /SAMPLE is a die and as such, does not receive 100% screening over temperature to the datasheet or DLA SMD requirements so, some level of fallout should be expected. These part types do not come with a Certificate of Conformance because there is no Radiation Assurance testing or items such as TCI/QCI, Burn-in, X-ray, SEM, etc.

TABLE 1. ISL7202xBSEH PRODUCT FAMILY FEATURES TABLE

SPECIFICATION	ISL72026BSEH	ISL72027BSEH	ISL72028BSEH
Loopback Feature	Yes	No	No
VREF Output	No	Yes	Yes
Listen Mode	Yes	Yes	No
Shutdown Mode	No	No	Yes
VTHRLM	1150mV (Maximum)	1150mV (Maximum)	N/A
VTHFLM	525mV (Minimum)	525mV (Minimum)	N/A
VHYSLM	50mV (Minimum)	50mV (Minimum)	N/A
Supply Current, Listen Mode	2mA (Maximum)	2mA (Maximum)	N/A
Supply Current, Shutdown Mode	N/A	N/A	50µA (Maximum)
VREF Leakage Current	N/A	±25μA (Maximum)	±25µA (Maximum)

N/A: Not Applicable

Pin Configuration



Note: The package lid is tied to ground.

Pin Descriptions

PIN #	PIN NAME	FUNCTION
1	D	CAN driver digital input. The bus states are LOW = Dominant and HIGH = Recessive. Internally tied HIGH.
2	GND	Ground connection.
3	VCC	System power supply input (3.0V to 3.6V). The typical voltage for the device is 3.3V.
4	R	CAN data receiver output. The bus states are LOW = Dominant and HIGH = Recessive.
5	VREF	VCC/2 reference output for split mode termination.
6	CANL	CAN bus line for high-level output.
7	CANH	CAN bus line for low-level output.
8		A resistor to GND from this pin controls the rise and fall time of the CAN output waveform. Drive RS HIGH to put into low power shutdown.

Equivalent Input and Output Schematic Diagrams

vcc



FIGURE 3. CANH AND CANL INPUTS



FIGURE 4. CANH OUTPUT

vcc



FIGURE 5. CANL OUTPUT



FIGURE 6. D INPUT



FIGURE 7. R OUTPUT



FIGURE 8. RS INPUT



Absolute Maximum Ratings

VCC to GND With/Without Ion Beam	0.3V to 5.5V
CANH, CANL, VREF Under Ion Beam	±18V
CANH, CANL, VREF	±20V
I/O Voltages	
D, R, RS	
Receiver Output Current	10mA to 10mA
Output Short-Circuit Duration	Continuous
ESD Rating:	
Human Body Model	
CANH, CANL Bus Pins (Tested per MIL-PRF	-883 3015.7) 4kV
All Other Pins (Tested per MIL-PRF-883 30	015.7)4kV
Charged Device Model (Tested per JESD22-C	101D) 750V
Machine Model (Tested per JESD22-A115-A)	

Thermal Information

Thermal Resistance (Typical)	θ_{JA} (°C/W)	θ _{JC} (°C/W)
8 Ld FP Package (<u>Notes 4</u> , <u>5</u>)	39	7
Maximum Junction Temperature		+175°C
Storage Temperature Range	6!	5°C to +150°C

Recommended Operating Conditions

Temperature Range	55°C to +125°C
V _{CC} Supply Voltage	3.0V to 3.6V
Voltage on CAN I/O	7V to 12V
VIH D Logic Pin	
VIL D Logic Pin	0V to 0.8V
I _{OH} Driver (CANH - CANL = 1.5V, V _{CC} = 3.3V)	40mA
I _{OH} Receiver (V _{OH} = 2.4V)	4mA
I _{OL} Driver (CANH - CANL = 1.5V, V _{CC} = 3.3V)	+40mA
I _{OL} Receiver (V _{OL} = 0.4V)	+4mA

CAUTION: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions may adversely impact product reliability and result in failures not covered by warranty.

NOTES:

- 4. θ_{JA} is measured with the component mounted on a high-effective thermal conductivity test board (two buried 1oz copper planes) with "direct attach" features package base mounted to PCB thermal land with a 10 mil gap fill material having a k of 1W/m-K. See Tech Brief <u>TB379</u>.
- 5. For $\theta_{\text{JC}}\text{, the "case temp" location is the center of the package underside.$

Electrical Specifications Test Conditions: $V_{CC} = 3.0V$ to 3.6V; typicals are at $T_A = +25$ °C (<u>Note 8</u>); unless otherwise specified (<u>Note 6</u>). Boldface limits apply across the operating temperature range, -55°C to +125°C; over a total ionizing dose of 75krad(SI) at +25°C with exposure at a low dose rate of <10mrad(SI)/s; and over a total ionizing dose of 100krad(SI) at +25°C with exposure of a high dose rate of 50krad(SI)/s.

PARAMETER	SYMBOL	TEST CONDITIC	INS	TEMP (°C)	MIN (<u>Note 7</u>)	TYP (<u>Note 8</u>)	MAX (<u>Note 7</u>)	UNIT
DRIVER ELECTRICAL CHARACTERISTICS								
Dominant Bus Output Voltage	V _{O(DOM)}	D = 0V, CANH, RS = 0V, <u>Figures 10</u> and <u>11</u>	$3.0V \le V_{CC} \le 3.6V$	Full	2.25	2.85	v _{cc}	v
		D = 0V, CANL, RS = 0V, <u>Figures 10</u> and <u>11</u>		Full	0.10	0.65	1.25	v
Recessive Bus Output Voltage	V _{O(REC)}	D = 3V, CANH, RS = 0V, 60Ω and no load, <u>Figures 10</u> and <u>11</u>	$3.0V \le V_{CC} \le 3.6V$	Full	1.80	2.30	2.70	v
		D = 3V, CANL, RS = 0V, 60Ω and no load, Figures 10 and 11		Full	1.80	2.30	2.80	v
Dominant Output Differential	V _{OD(DOM)}	$D = 0V, RS = 0V, 3.0V \le V_{CC} \le 3.6$	W, Figures 10 and 11	Full	1.5	2.2	3.0	v
Voltage		$D = 0V, RS = 0V, 3.0V \le V_{CC} \le 3.6$	6V, <u>Figures 11</u> and <u>12</u>	Full	1.2	2.1	3.0	v
Recessive Output Differential	V _{OD(REC)}	D = 3V, RS = 0V, $3.0V \le V_{CC} \le 3.6$	6V, <u>Figures 10</u> and <u>11</u>	Full	-120	0.2	12	m٧
Voltage		$D = 3V, RS = 0V, 3.0V \le V_{CC} \le 3.6$	SV, no load	Full	-500	-34	50	mV
Logic Input High Voltage (D)	VIH	3.0V ≤ V _{CC} ≤ 3.6V, <u>Note 9</u>		Full	2.0	-	5.5	v
Logic Input Low Voltage (D)	V _{IL}	3.0V ≤ V _{CC} ≤ 3.6V, <u>Note 9</u>		Full	0	-	0.8	v
High-Level Input Current (D)	IIH	$D = 2.0V, 3.0V \le V_{CC} \le 3.6V$		Full	-30	-3	30	μA
Low-Level Input Current (D)	Ι _{ΙL}	$D = 0.8V, 3.0V \le V_{CC} \le 3.6V$		Full	-30	-7	30	μA
RS Input Voltage for Low-Power Shutdown Mode	V _{IN(RS)}	$3.0V \le V_{CC} \le 3.6V$		Full	0.75 x V _{CC}	1.9	5.5	v

Electrical Specifications Test Conditions: $V_{CC} = 3.0V$ to 3.6V; typicals are at $T_A = +25^{\circ}C$ (<u>Note 8</u>); unless otherwise specified (<u>Note 6</u>). Boldface limits apply across the operating temperature range, -55°C to +125°C; over a total ionizing dose of 75krad(Si) at +25°C with exposure at a low dose rate of <10mrad(Si)/s; and over a total ionizing dose of 100krad(Si) at +25°C with exposure of a high dose rate of 50krad(Si)/s. to 300krad(Si)/s. (Continued)

PARAMETER	SYMBOL	TEST CONDITIONS	TEMP (°C)	MIN (<u>Note 7</u>)	TYP (<u>Note 8</u>)	MAX (<u>Note 7</u>)	UNIT
Output Short-Circuit Current	losc	$V_{CANH} = -7V$, CANL = OPEN, $3.0V \le V_{CC} \le 3.6V$, Figure 17	Full	-250	-100	-	mA
		V_{CANH} = +12V, CANL = OPEN, 3.0V $\leq V_{CC} \leq$ 3.6V, Figure 17	Full	-	0.4	1.0	mA
		$V_{CANL} = -7V$, CANH = OPEN, $3.0V \le V_{CC} \le 3.6V$, Figure 17	Full	-1.0	-0.4	-	mA
		V_{CANL} = +12V, CANH = OPEN, 3.0V $\leq V_{CC} \leq$ 3.6V, Figure 17	Full	-	100	250	mA
Thermal Shutdown Temperature	T _{SHDN}	3.0V < V _{IN} < 3.6V	-	-	163	-	°C
Thermal Shutdown Hysteresis	T _{HYS}	3.0V < V _{IN} < 3.6V	-	-	12	-	°C
RECEIVER ELECTRICAL CHARACTEI	RISTICS	L			1 1		
Input Threshold Voltage (Rising)	V _{THR}	RS = 0V, 10k, 50k, (recessive to dominant), Figures 14 and 15	Full	-	750	900	mV
Input Threshold Voltage (Falling)	V _{THF}	RS = 0V, 10k, 50k, (dominant to recessive), Figures 14 and 15	Full	500	650	-	mV
Input Hysteresis	V _{HYS}	(V _{THR} - V _{THF}), RS = 0V, 10k, 50k, <u>Figures 14</u> and <u>15</u>	Full	40	90	-	mV
Receiver Output High Voltage	V _{OH}	I ₀ = -4mA	Full	2.4	V _{CC} - 0.2	-	v
Receiver Output Low Voltage	V _{OL}	I _O = +4mA	Full	-	0.2	0.4	v
Input Current for CAN Bus	ICAN	CANH or CANL at 12V, D = 3V, other bus pin at 0V, $RS = 0V$	Full	-	420	500	μA
		CANH or CANL at 12V, D = 3V, V_{CC} = 0V, other bus pin at 0V, RS = 0V	Full	-	150	250	μA
		CANH or CANL at -7V, D = 3V, other bus pin at 0V, $RS = 0V$	Full	-400	-300	-	μA
		CANH or CANL at -7V, D = 3V, V_{CC} = 0V, other bus pin at 0V, RS = 0V	Full	-150	-85	-	μA
Input Capacitance (CANH or CANL)	C _{IN}	Input to GND, D = 3V, RS = 0V	25	-	35	-	pF
Differential Input Capacitance	C _{IND}	Input to input, D = 3V, RS = 0V	25	-	15	-	pF
Input Resistance (CANH or CANL)	R _{IN}	Input to GND, D = 3V, RS = 0V	Full	20	40	50	kΩ
Differential Input Resistance	R _{IND}	Input to input, D = 3V, RS = 0V	Full	40	80	100	kΩ
SUPPLY CURRENT							
Supply Current, Low-Power Shutdown Mode	I _{CC(LPS)}	$RS = D = V_{CC}, 3.0V \le V_{CC} \le 3.6V, Note 10$	Full	-	20	50	μA
Supply Current, Dominant	I _{CC(DOM)}	D = RS = 0V, no load, $3.0V \le V_{CC} \le 3.6V$	Full	-	5	7	mA
Supply Current, Recessive	I _{CC(REC)}	$D = V_{CC}$, RS = 0V, no load, $3.0V \le V_{CC} \le 3.6V$	Full	-	2.6	5.0	mA
COLD SPARING BUS CURRENT							
CANH Leakage Current	I _{L(CANH)}	V_{CC} = 0.2V, CANH = -7V or 12V, D = V_{CC} , CANL = float, RS = 0V	Full	-25	-4	25	μA
CANL Leakage Current	I _{L(CANL)}	$V_{CC} = 0.2V$, CANL = -7V or 12V, D = V_{CC} , CANH = float, RS = 0V	Full	-25	-4	25	μA
VREF Leakage Current	I _{L(VREF)}	$V_{CC} = 0.2V, V_{REF} = -7V \text{ or } 12V, D = V_{CC}$	Full	-25.00	0.01	25.00	μA
DRIVER SWITCHING CHARACTERIS							
Propagation Delay LOW to HIGH	t _{PDLH1}	RS = 0V, <u>Figure 13</u>	Full	-	75	150	ns
Propagation Delay LOW to HIGH	t _{PDLH2}	RS = 10kΩ, <u>Figure 13</u>	Full	-	520	850	ns
Propagation Delay LOW to HIGH t _{PDLH3} RS = 50kΩ, <u>Figure 13</u>		Full	-	850	1400	ns	
Propagation Delay HIGH to LOW	t _{PDHL1}	RS = 0V, <u>Figure 13</u>	Full	-	80	155	ns



Electrical Specifications Test Conditions: $V_{CC} = 3.0V$ to 3.6V; typicals are at $T_A = +25$ °C (<u>Note 8</u>); unless otherwise specified (<u>Note 6</u>). Boldface limits apply across the operating temperature range, -55°C to +125°C; over a total ionizing dose of 75krad(Si) at +25°C with exposure at a low dose rate of <10mrad(Si)/s; and over a total ionizing dose of 100krad(Si) at +25°C with exposure of a high dose rate of 50krad(Si)/s. to 300krad(Si)/s. (Continued)

PARAMETER	SYMBOL	TEST CONDITIONS	TEMP (°C)	MIN (<u>Note 7</u>)	TYP (<u>Note 8</u>)	MAX (<u>Note 7</u>)	UNIT
Propagation Delay HIGH to LOW	t _{PDHL2}	RS = 10kΩ, <u>Figure 13</u>	Full	-	460	800	ns
Propagation Delay HIGH to LOW	t _{PDHL3}	RS = 50kΩ, <u>Figure 13</u>	Full	-	725	1300	ns
Output Skew	t _{SKEW1}	RS = 0V, (t _{PHL} - t _{PLH}), <u>Figure 13</u>	Full	-	5	50	ns
Output Skew	t _{SKEW2}	RS = $10k\Omega$, ($ t_{PHL} - t_{PLH} $), Figure 13	Full	-	60	510	ns
Output Skew	t _{SKEW3}	RS = 50kΩ, ($ t_{PHL} - t_{PLH} $), <u>Figure 13</u>	Full	-	110	800	ns
Output Rise Time	t _{r1}	RS = 0V, (fast speed) <u>Figure 13</u>	Full	20	55	100	ns
Output Fall Time	t _{f1}		Full	10	25	75	ns
Output Rise Time	t _{r2}	RS = 10kΩ, (medium speed - 250Kbps) <u>Figure 13</u>	Full	200	400	780	ns
Output Fall Time	t _{f2}		Full	175	300	500	ns
Output Rise Time	t _{r3}	RS = $50k\Omega$, (slow speed - 125Kbps) <u>Figure 13</u>	Full	400	700	1400	ns
Output Fall Time	t _{f3}		Full	300	650	1000	ns
Total Loop Delay, Driver Input to	t _(LOOP1)	RS = 0V, <u>Figure 15</u>	Full	-	115	210	ns
Receiver Output, Recessive to		RS = 10kΩ, <u>Figure 15</u>	Full	-	550	875	ns
Dominant		RS = 50kΩ, <u>Figure 15</u>	Full	-	850	1400	ns
Total Loop Delay, Driver Input to	t _(LOOP2)	RS = 0V, <u>Figure 15</u>	Full	-	130	270	ns
Receiver Output, Dominant to		RS = 10kΩ, <u>Figure 15</u>	Full	-	500	825	ns
Recessive		RS = 50kΩ, <u>Figure 15</u>	Full	-	750	1300	ns
Low-Power Shutdown to Valid Dominant Time	^t lps_dom	Figure 16, Note 10	Full	-	6	15	μs
RECEIVER SWITCHING CHARACTE	RISTICS						
Propagation Delay LOW to HIGH	t _{PLH}	Figure 14	Full	-	50	110	ns
Propagation Delay HIGH to LOW	t _{PHL}	Figure 14	Full	-	50	110	ns
Rx Skew	tskew1	(t _{PHL} - t _{PLH}) , <u>Figure 14</u>	Full	-	2	35	ns
Rx Rise Time	t _r	Figure 14	Full	-	2	-	ns
Rx Fall Time	t _f	Figure 14	Full	-	2	-	ns
VREF/RS PIN CHARACTERISTICS				1		1	
VREF Pin Voltage	VREF	-5μΑ < Ι _{REF} < 5μΑ	Full	0.45 x V _{CC}	1.6	0.55 x V _{CC}	v
		-50μΑ < I _{REF} < 50μΑ	Full	0.40 x V _{CC}	1.6	0.60 x V _{CC}	v
RS Pin Input Current	I _{RS(H)}	$RS = 0.75 x V_{CC}$	Full	-10.0	-0.2	-	μA
NOTES	I _{RS(L)}	V _{RS} = 0V	Full	-450	-125	0	μA

NOTES:

6. All currents into device pins are positive; all currents out of device pins are negative. All voltages are referenced to device ground unless otherwise specified.

7. Parameters with MIN and/or MAX limits are 100% tested at -55 $^\circ$ C, +25 $^\circ$ C and +125 $^\circ$ C, unless otherwise specified.

8. Typical values are at 3.3V. Parameters with a single entry in the "TYP" column apply to 3.3V. Typical values shown are not guaranteed.

9. Parameter included in functional testing.

10. Performed during the 100% screening operations across the full operating temperature range. Not performed as part of TCI Group E and Group C. Radiation characterization testing performed as part of the initial release and any major changes in design.

Test Circuits and Waveforms



FIGURE 10. DRIVER TEST CIRCUIT



FIGURE 11. DRIVER BUS VOLTAGE DEFINITIONS







 V_{IN} = 125kHz, 0V to V_{CC} , Duty Cycle 50%, t_r = t_f ≤ 6ns, Z_O = 50Ω C_L includes fixture and instrumentation capacitance FIGURE 13A. DRIVER TIMING TEST CIRCUIT











 V_{IN} = 125kHz, Duty Cycle 50%, t_r = $t_f \leq$ 6ns, Z_O = 50 Ω CL includes test setup capacitance

FIGURE 14B. RECEIVER TEST CIRCUIT



FIGURE 14A. RECEIVER VOLTAGE DEFINITIONS

FIGURE 14. RECEIVER TEST

PUT	OUTPUT	MEASURED				
VCANL	R	V _{DIFF}				
-7V	L	900mV				
11.1V	L	900mV				
-7V	L	6V				
6V	L	6V				
-7V	н	500mV				
11.5V	Н	500mV				
-1V	Н	6V				
12V	н	6V				
Open	н	х				
	VCANL -7V 11.1V -7V 6V -7V 11.5V -1V 12V	VCANL R -7V L 11.1V L -7V L 6V L -7V H 11.5V H -1V H 12V H				

TABLE 2. DIFFERENTIAL INPUT VOLTAGE THRESHOLD TEST

Test Circuits and Waveforms (Continued)



V_{IN} = 125kHz, Duty Cycle 50%, t_r = t_f ≤ 6ns

FIGURE 15A. TOTAL LOOP DELAY TEST CIRCUIT



FIGURE 15B. TOTAL LOOP DELAY MEASUREMENT POINTS







 V_{IN} = 125kHz, 0V to V_{CC} , Duty Cycle 50%, $t_r = t_f \le 6$ ns.

FIGURE 16A. LOW-POWER SHUTDOWN TO DOMINANT TIME CIRCUIT

FIGURE 16B. LOW-POWER SHUTDOWN TO DOMINANT TIME MEASUREMENT POINTS





FIGURE 17A. OUTPUT SHORT-CIRCUIT CURRENT CIRCUIT

FIGURE 17B. OUTPUT SHORT-CIRCUIT CURRENT WAVEFORMS

FIGURE 17. OUTPUT SHORT-CIRCUIT

Functional Description

Overview

The ISL72028BSEH is a 3.3V radiation tolerant CAN transceiver that is compatible with the ISO11898-2 standard for use in Controller Area Network (CAN) serial communication systems.

The device performs transmit and receive functions between the CAN controller and the CAN differential bus. It can transmit and receive at bus speeds of up to 5Mbps. It is designed to operate over a common-mode range of -7V to +12V with a maximum of 120 nodes. The device is capable of withstanding ±20V on the CANH and CANL bus pins outside of ion beam and ±16V under ion beam.

Slope Adjustment

The output driver rise and fall time has three distinct selections that may be chosen by using a resistor from the RS pin to GND. Connecting the RS pin directly to GND results in output switching times that are the fastest, limited only by the drive capability of the output stage. RS = $10k\Omega$ provides for a typical slew rate of $8V/\mu s$ and RS = $50k\Omega$ provides for a typical slew rate of $4V/\mu s$.

Putting a high logic level to the RS pin places the device in a Low-Power Shutdown mode. The protocol controller uses this mode to switch between Low-Power Shutdown mode and Normal Transmit mode.

Cable Length

The device can work per ISO11898 specification with a 40m cable and stub length of 0.3m and 60 nodes at 1Mbps. This is greater than the ISO requirement of 30 nodes. The cable type specified is a twisted pair (shielded or unshielded) with a characteristic impedance of 120Ω . Resistors equal to this are to be terminated at both ends of the cable. Stubs should be kept as short as possible to prevent reflections.

Cold Spare

High reliability system designers implementing data communications have to be sensitive to the potential for single point failures. To mitigate the risk of a failure, they will use redundant bus transceivers in parallel. In this arrangement, both active and quiescent devices can be present simultaneously on the bus. The quiescent devices are powered down for cold spare and do not affect the communication of the other active nodes.

To achieve this, a powered-down transceiver (V_{CC} < 200mV) has a resistance between the VREF pin, the CANH pin, or the CANL pin and the VCC supply rail of >480k Ω (maximum) with a typical resistance >2M Ω . The resistance between CANH and CANL of a powered-down transceiver has a typical resistance of 80k Ω .

Low-Power Shutdown Mode

When a high level is applied to the RS pin, the device enters the Low-Power Shutdown mode in which the driver and receiver are switched off to conserve power. The bus pins are at High Z and the R pin will be at logic high. In Low-Power Shutdown the transceiver draws $50\mu A$ (max) of current.

A low level on the RS pin brings the device back to operation.

Using 3.3V Devices in 5V Systems

Looking at the differential voltage of both the 3.3V and 5V devices, the differential voltage is the same, the recessive common-mode output is the same. The dominant common-mode output voltage is slightly lower than the 5V counterparts. The receiver specifications are also the same. Though the electrical parameters appear compatible, it is advised that necessary system testing be performed to verify interchangeable operation.

Split Mode Termination

The VREF pin provides a $V_{CC}/2$ output voltage for Split mode termination. The VREF pin has the same ESD protection, short-circuit protection and common-mode operating range as the bus pins.

The Split mode termination technique is shown in Figure 18.



FIGURE 18. SPLIT TERMINATION

It is used to stabilize the bus voltage at V_{CC}/2 and prevent it from drifting to a high common-mode voltage during periods of inactivity. The technique improves the electromagnetic compatibility of a network. The Split mode termination is put at each end of the bus.

The C_L capacitor between the two 60Ω resistors, filters unwanted high frequency noise to ground. The resistors should have a tolerance of 1% or better and the two resistors should be carefully matched to provide the most effective EMI immunity. A typical value of C_L for a high speed CAN network is 4.7nF, which generates a 3dB point at 1.1Mbps. The capacitance value used is dependent on the signaling rate of the network.

Typical Performance Curves $c_L = 15pF$, $T_A = +25°C$; unless otherwise specified.

















FIGURE 22. BUS PIN LEAKAGE vs V_{CM} AT $V_{CC} = 0V$



Typical Performance Curves $C_L = 15pF$, $T_A = +25$ °C; unless otherwise specified. (Continued)





FIGURE 26. TRANSMITTER PROPAGATION DELAY AND SKEW vs TEMPERATURE AT FAST SPEED



FIGURE 27. TRANSMITTER PROPAGATION DELAY AND SKEW vs TEMPERATURE AT MEDIUM SPEED



FIGURE 29. TRANSMITTER RISE AND FALL TIMES vs TEMPERATURE AT FAST SPEED



FIGURE 28. TRANSMITTER PROPAGATION DELAY AND SKEW vs TEMPERATURE AT SLOW SPEED





Typical Performance Curves $C_L = 15pF$, $T_A = +25$ °C; unless otherwise specified. (Continued)







FIGURE 33. DRIVER OUTPUT CURRENT vs SHORT-CIRCUIT VOLTAGE vs TEMPERATURE





FIGURE 32. DRIVER OUTPUT CURRENT vs DIFFERENTIAL OUTPUT VOLTAGE



FIGURE 34. DRIVER OUTPUT CURRENT vs SHORT-CIRCUIT VOLTAGE vs TEMPERATURE





Typical Performance Curves $C_L = 15pF$, $T_A = +25$ °C; unless otherwise specified. (Continued)







FIGURE 38. RECEIVER RISE AND FALL TIMES vs TEMPERATURE



Die Characteristics

Die Dimensions

 $2413\mu m x 3322\mu m$ (95 mils x 130.79 mils) Thickness: $305\mu m \pm 25\mu m$ (12 mils ± 1 mil)

Interface Materials

GLASSIVATION

Type: 12kÅ Silicon Nitride on 3kÅ Oxide

TOP METALLIZATION

Type: 300Å TiN on 2.8µm AlCu In Bondpads, TiN has been removed.

BACKSIDE FINISH

Silicon

PROCESS

P6S0I

Metalization Mask Layout

Assembly Related Information

SUBSTRATE POTENTIAL

Floating

Additional Information

WORST CASE CURRENT DENSITY 1.6×10^{5} A/cm²

TRANSISTOR COUNT

4055

Weight of Packaged Device

0.31 grams

Lid Characteristics

Finish: Gold Potential: Grounded, tied to package pin 2



ISL72028BSEH

TABLE 3. ISL72028BSEH DIE LAYOUT X-Y COORDINATES								
PAD NUMBER	PAD NAME	Χ (μm)	Υ (μm)	x	Y			
1	NC	90.0	90.0	901.4	1365.6			
2	NC	90.0	90.0	767.4	1365.6			
3	NC	90.0	90.0	-183.23	1365.6			
4	NC	90.0	90.0	-333.25	1365.6			
5	NC	90.0	90.0	-483.25	1365.6			
6	NC	90.0	90.0	-633.25	1365.6			
7	NC	90.0	90.0	-783.25	1365.6			
8	NC	90.0	90.0	-933.25	1365.6			
9	D	110.0	110.0	-931.1	901.85			
10	GND_LSPD	110.0	110.0	-931.1	563.25			
11	GND	110.0	180.0	-931.1	342.25			
12	GND_ESD	110.0	110.05	-931.1	119.42			
13	VCC	110.0	180.0	-931.1	-115.05			
14	VCC_VREF	110.0	180.05	-931.1	-371.08			
15	R	110.0	180.0	-931.1	-1350.0			
16	NC	90.0	90.0	-711.1	-1394.95			
17	NC	90.0	90.0	-561.1	-1394.95			
18	NC	90.0	90.0	-411.1	-1394.95			
19	NC	90.0	90.0	-261.1	-1394.95			
20	NC	90.0	90.0	-111.1	-1394.95			
21	NC	90.0	90.0	38.9	-1394.95			
22	NC	110.0	110.0	756.9	-1307.3			
23	VREF	110.0	180.0	775.3	-1072.3			
24	CANL	110.0	180.0	772.1	2.15			
25	CANH	110.0	180.05	772.1	343.33			
26	RS	110.0	180.0	848.1	1140.6			

TABLE 3. ISL72028BSEH DIE LAYOUT X-Y COORDINATES

NOTE: Origin of coordinates is the center of the die. NC - No Connect

Revision History	The revision history provided is for informational purposes only and is believed to be accurate, but not warranted.
Please visit our website to make sure that you have the latest revision.	

DATE	REVISION	CHANGE
November 30, 2016	FN8902.0	Initial Release

Package Outline Drawing

For the most recent package outline drawing, see <u>K8.A</u>.

K8.A

8 LEAD CERAMIC METAL SEAL FLATPACK PACKAGE

Rev 4, 12/14





SIDE VIEW



NOTES:

- Index area: A notch or a pin one identification mark shall be located adjacent to pin one and shall be located within the shaded area shown. The manufacturer's identification shall not be used as a pin one identification mark. Alternately, a tab may be used to identify pin one.
- $\frac{2}{2}$ If a pin one identification mark is used in addition to or instead of a tab, the limits of the tab dimension do not apply.
- 7. The maximum limits of lead dimensions (section A-A) shall be measured at the centroid of the finished lead surfaces, when solder dip or tin plate lead finish is applied.
- 4. Measure dimension at all four corners.
- 5. For bottom-brazed lead packages, no organic or polymeric materials shall be molded to the bottom of the package to cover the leads.
- Dimension shall be measured at the point of exit (beyond the meniscus) of the lead from the body. Dimension minimum shall be reduced by 0.0015 inch (0.038mm) maximum when solder dip lead finish is applied.
- 7. Dimensioning and tolerancing per ANSI Y14.5M 1982.
- 8. Controlling dimension: INCH.

Notice

- 1. Descriptions of circuits, software and other related information in this document are provided only to illustrate the operation of semiconductor products and application examples. You are fully responsible for the incorporation or any other use of the circuits, software, and information in the design of your product or system. Renesas Electronics disclaims any and all liability for any losses and damages incurred by you or third parties arising from the use of these circuits, software, or information
- 2. Renesas Electronics hereby expressly disclaims any warranties against and liability for infringement or any other claims involving patents, copyrights, or other intellectual property rights of third parties, by or arising from the use of Renesas Electronics products or technical information described in this document, including but not limited to, the product data, drawings, charts, programs, algorithms, and application examples.
- 3. No license, express, implied or otherwise, is granted hereby under any patents, copyrights or other intellectual property rights of Renesas Electronics or others.
- 4. You shall not alter, modify, copy, or reverse engineer any Renesas Electronics product, whether in whole or in part. Renesas Electronics disclaims any and all liability for any losses or damages incurred by you or third parties arising from such alteration, modification, copying or reverse engineering.
- 5. Renesas Electronics products are classified according to the following two quality grades: "Standard" and "High Quality". The intended applications for each Renesas Electronics product depends on the product's quality grade, as indicated below.
 - Computers; office equipment; communications equipment; test and measurement equipment; audio and visual equipment; home electronic appliances; machine tools; personal electronic "Standard": equipment; industrial robots; etc.

"High Quality": Transportation equipment (automobiles, trains, ships, etc.); traffic control (traffic lights); large-scale communication equipment; key financial terminal systems; safety control equipment; etc.

Unless expressly designated as a high reliability product or a product for harsh environments in a Renesas Electronics data sheet or other Renesas Electronics document, Renesas Electronics products are not intended or authorized for use in products or systems that may pose a direct threat to human life or bodily injury (artificial life support devices or systems; surgical implantations; etc.), or may cause serious property damage (space system; undersea repeaters; nuclear power control systems; aircraft control systems; key plant systems; military equipment; etc.). Renesas Electronics disclaims any and all liability for any damages or losses incurred by you or any third parties arising from the use of any Renesas Electronics product that is inconsistent with any Renesas Electronics data sheet, user's manual or other Renesas Electronics document.

- 6. When using Renesas Electronics products, refer to the latest product information (data sheets, user's manuals, application notes, "General Notes for Handling and Using Semiconductor Devices" in the reliability handbook, etc.), and ensure that usage conditions are within the ranges specified by Renesas Electronics with respect to maximum ratings, operating power supply voltage range, heat dissipation characteristics, installation, etc. Renesas Electronics disclaims any and all liability for any malfunctions, failure or accident arising out of the use of Renesas Electronics products outside of such specified ranges
- 7. Although Renesas Electronics endeavors to improve the quality and reliability of Renesas Electronics products, semiconductor products have specific characteristics, such as the occurrence of failure at a certain rate and malfunctions under certain use conditions. Unless designated as a high reliability product or a product for harsh environments in a Renesas Electronics data sheet or other Renesas Electronics document, Renesas Electronics products are not subject to radiation resistance design. You are responsible for implementing safety measures to guard against the possibility of bodily injury, injury or damage caused by fire, and/or danger to the public in the event of a failure or malfunction of Renesas Electronics products, such as safety design for hardware and software, including but not limited to redundancy, fire control and malfunction prevention, appropriate treatment for aging degradation or any other appropriate measures. Because the evaluation of microcomputer software alone is very difficult and impractical, you are responsible for evaluating the safety of the final products or systems manufactured by you.
- 8. Please contact a Renesas Electronics sales office for details as to environmental matters such as the environmental compatibility of each Renesas Electronics product. You are responsible for carefully and sufficiently investigating applicable laws and regulations that regulate the inclusion or use of controlled substances, including without limitation, the EU RoHS Directive, and using Renesas Electronics products in compliance with all these applicable laws and regulations. Renesas Electronics disclaims any and all liability for damages or losses occurring as a result of your noncompliance with applicable laws and regulations
- 9. Renesas Electronics products and technologies shall not be used for or incorporated into any products or systems whose manufacture, use, or sale is prohibited under any applicable domestic or foreign laws or regulations. You shall comply with any applicable export control laws and regulations promulgated and administered by the governments of any countries asserting jurisdiction over the parties or
- 10. It is the responsibility of the buyer or distributor of Renesas Electronics products, or any other party who distributes, disposes of, or otherwise sells or transfers the product to a third party, to notify such third party in advance of the contents and conditions set forth in this document.
- 11. This document shall not be reprinted, reproduced or duplicated in any form, in whole or in part, without prior written consent of Renesas Electronics.
- 12. Please contact a Renesas Electronics sales office if you have any questions regarding the information contained in this document or Renesas Electronics products.
- (Note 1) "Renesas Electronics" as used in this document means Renesas Electronics Corporation and also includes its directly or indirectly controlled subsidiaries
- (Note 2) "Renesas Electronics product(s)" means any product developed or manufactured by or for Renesas Electronics

(Rev.4.0-1 November 2017)

RENESAS

Renesas Electronics Corporation

http://www.renesas.com

SALES OFFICES

Refer to "http://www.renesas.com/" for the latest and detailed information.

Renesas Electronics America Inc.

1001 Murphy Ranch Road, Milpitas, CA 95035, U.S.A. Tel: +1-408-432-8888, Fax: +1-408-434-5351

Renesas Electronics Canada Limited 9251 Yonge Street, Suite 8309 Richmond Hill, Ontario Canada L4C 9T3 Tel: +1-905-237-2004

Renesas Electronics Europe Limited Dukes Meadow, Millboard Road, Bourne End, Buckinghamshire, SL8 5FH, U.K Tel: +44-1628-651-700, Fax: +44-1628-651-804

Renesas Electronics Europe GmbH

Arcadiastrasse 10, 40472 Düsseldorf, Germany Tel: +49-211-6503-0, Fax: +49-211-6503-1327

Renesas Electronics (China) Co., Ltd. Room 1709 Quantum Plaza, No.27 ZhichunLu, Haidian District, Beijing, 100191 P. R. China Tel: +86-10-8235-1155, Fax: +86-10-8235-7679

Renesas Electronics (Shanghai) Co., Ltd.

Unit 301, Tower A, Central Towers, 555 Langao Road, Putuo District, Shanghai, 200333 P. R. China Tel: +86-21-2226-0888, Fax: +86-21-2226-0999

Renesas Electronics Hong Kong Limited Unit 1601-1611, 16/F., Tower 2, Grand Cent Tel: +852-2265-6688, Fax: +852 2886-9022 ntury Place, 193 Prince Edward Road West, Mongkok, Kowloon, Hong Kong

Renesas Electronics Taiwan Co., Ltd.

13F, No. 363, Fu Shing North Road, Taipei 10543, Taiwan Tel: +886-2-8175-9600, Fax: +886 2-8175-9670

Renesas Electronics Singapore Pte. Ltd. 80 Bendemeer Road, Unit #06-02 Hyflux Innovation Centre, Singapore 339949 Tel: +65-6213-0200, Fax: +65-6213-0300

Renesas Electronics Malavsia Sdn.Bhd. Unit 1207, Block B, Menara Amcorp, Amcorp Trade Centre, No. 18, Jin Persiaran Barat, 46050 Petaling Jaya, Selangor Darul Ehsan, Malaysia Tel: +60-3-7955-9390, Fax: +60-3-7955-9510

Renesas Electronics India Pvt. Ltd. No.777C, 100 Feet Road, HAL 2nd Stage, Indiranagar, Bangalore 560 038, India Tel: +91-80-67208700, Fax: +91-80-67208777 Renesas Electronics Korea Co., Ltd. 17F, KAMCO Yangjae Tower, 262, Gangnam-daero, Gangnam-gu, Seoul, 06265 Korea Tel: +82-2-558-3737, Fax: +82-2-558-5338

> © 2018 Renesas Electronics Corporation. All rights reserved. Colophon 7.0